Amendments to the Claims:

This listing of claims will replace all prior versions, and listings, of claims in the application:

Listing of claims:

Claim 1 (currently amended). An electronic component, comprising:

a chip stack including a first semiconductor chip having an active surface and a second semiconductor chip having an active surface;

a plurality of flat conductors, each one of said plurality of flat conductors including an inner section, a central section, a transitional section, and an outer section, said inner section of each one of said plurality of flat conductors and said central section of each one of said plurality of flat conductors configured between said first semiconductor chip and said second semiconductor chip;

a package;

a plurality of first bonding connections; and

a plurality of second bonding connections;

Applic. No.: 10/723,906 Amdt. Dated June 27, 2005

Reply to Office action of March 25, 2005

said first semiconductor chip having a plurality of contact surfaces;

said second semiconductor chip having a plurality of contact surfaces;

said contact surfaces of said first semiconductor chip and said second semiconductor chip being disposed at mutually congruent positions;

a first interposer layer or interposer film configured on said active surface of said first semiconductor chip, said first interposer layer or interposer film having first bonding fingers, first interposer lines and first bonding surfaces; and

a second interposer layer or interposer film configured on said active surface of said second semiconductor chip, said second interposer layer or interposer film having second bonding fingers, second interposer lines and second bonding surfaces;

each one of said plurality of first bonding connections connecting one of said first bonding surfaces on said first

interposer layer or interposer film to said inner section of one of said plurality of flat conductors; and

each one of said plurality of second bonding connections connecting one of said second bonding surfaces on said second interposer layer or interposer film to said transitional section of one of said plurality of flat conductors.

Claim 2 (original). The electronic component according to claim 1, wherein:

one of said plurality of first bonding connections is connected to said inner section of a given one of said plurality of flat conductors; and

one of said plurality of second bonding connections is connected to said transitional section of said given one of said plurality of flat conductors.

Claim 3 (previously presented). The electronic component according to claim 1, wherein:

said plurality of said first bonding surfaces on said first interposer layer or interposer film and said plurality of said second bonding surfaces on said second interposer layer or

Applic. No.: 10/723,906 Amdt. Dated June 27, 2005 Reply to Office action of March 25, 2005

interposer film are configured at mutually congruent positions.

Claim 4 (original). The electronic component according to claim 1, wherein:

said first semiconductor chip includes a bonding channel and said second semiconductor chip includes a bonding channel congruently configured with respect to said bonding channel of said first semiconductor chip;

said plurality of bonding surfaces on said first semiconductor chip are configured in said bonding channel of said first semiconductor chip; and

said plurality of bonding surfaces on said first semiconductor chip are configured in said bonding channel of said first semiconductor chip.

Claim 5 (cancelled).

Claim 6 (previously presented). The electronic component according to claim 1, wherein:

said active surface of said first semiconductor chip is mounted on said central section of each one of said plurality of flat conductors; and

said active surface of said second semiconductor chip is mounted on said central section of each one of said plurality of flat conductors.

Claim 7 (previously presented). The electronic component according to claim 1, wherein:

said outer section of each one of said plurality of flat conductors has a z-shaped bend aligned such that said active surface of said first semiconductor chip and said active surface of said second semiconductor chip are aligned in a direction of the bend.

Claim 8 (previously presented). The electronic component according to claim 1, wherein:

said outer section of each one of said plurality of flat conductors has a z-shaped bend aligned such that said active surface of said first semiconductor chip and said active surface of said second semiconductor chip are aligned in a direction opposite the bend.

Reply to Office action of March 25, 2005

Claim 9 (previously presented). The electronic component according to claim 1, wherein:

said transitional section of each one of said plurality of flat conductors has a bend toward said active surface of said second semiconductor chip.

Claim 10 (withdrawn - currently amended). A method for producing an electronic component, the method which comprises:

providing a first semiconductor chip having an active surface and a plurality of contact surfaces and a second semiconductor chip having an active surface and a plurality of contact surfaces, the first semiconductor chip and the second semiconductor chip being for a chip stack, the contact surfaces of the first semiconductor chip and the second semiconductor chip being disposed at mutually congruent positions;

providing a plurality of flat conductors, each one of the plurality of flat conductors including an inner section, a central section, a transitional section, and an outer section, the inner section of each one of the plurality of flat conductors and the central section of each one of said the

plurality of flat conductors configured between the first semiconductor chip and the second semiconductor chip;

providing a plurality of first bonding connections and a plurality of second bonding connections;

fitting a first interposer layer or interposer film to the active surface of the first semiconductor chip, the first interposer layer or interposer film having first bonding fingers, first interposer lines and first bonding surfaces;

fitting a second interposer layer or interposer film to the active surface of the second semiconductor chip, the second interposer layer or interposer film having second bonding fingers, second interposer lines and second bonding surfaces;

connecting one of the first bonding surfaces on the first interposer layer or interposer film to the inner section of one of the plurality of flat conductors though each one of the plurality of first bonding connections;

connecting one of the second bonding surfaces on the second interposer layer or interposer film to the transitional section of one of the plurality of flat conductors through each one of the plurality of second bonding connections; and

packaging a chip stack formed by the first semiconductor chip, the second semiconductor chip, the plurality of first bonding connections, the plurality of second bonding connections, and the plurality of flat conductors in a plastic encapsulation compound, leaving outer sections of the flat conductors of the flat conductor frame projecting.

Claim 11 (original). The method according to claim 10, which further comprises:

after the chip stack has been packaged, stamping out the component position from the flat conductor frame, and bending the outer section of the plurality of flat conductors.

Claim 12 (cancelled).